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Adhesion trends and growth mode of ultra-thin copper films on MgO

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Abstract

Ab initio simulations are performed for Cu atoms adsorbed on the perfect MgO(001) substrate, with an ordered metal coverage varied from $\frac{1}{4}$ monolayer (ML), i.e. almost single atoms, up to 1 ML. A strong dependence of the adhesion energy and the sub-monolayer film distance from the substrate on the surface coverage and adsorbate positions (Mg^{2+} or O^{2-}) is discussed. The nature of interfacial bonding at all coverages is *physisorption*. When increasing Cu atomic fraction, a decrease of the substrate-induced polarization of adatoms accompanied by an increase of both in-plane metallic bonding and the interfacial distance has been found. Combining results of *ab initio* calculations with thermodynamic theory (taking into account the lattice mismatch), we show that the metal cluster formation becomes the predominant growth mode even at low Cu coverages, in agreement with experiment.

(Some figures in this article are in colour only in the electronic version)

1. Introduction

The practical importance of even relatively simple metal/oxide systems, such as copper atoms adsorbed on a MgO substrate, assumes a variety of guises. In particular, advancing the scientific design of catalysts and coatings is of scientific, environmental and engineering interest [1]. Just

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as the study of systematic trends led, through the image potential model [2], to understanding of the role of substrate properties and of radiation-enhanced adhesion, so should a study of trends with metal coverage give important insights. Although experimental advances now allow fairly in-depth characterization of many adsorbate–surface systems, a comparable level of detailed experimental characterization at heterogeneous interfaces generally remains elusive. Reasons for this discrepancy are clear when one considers the experimental limitations [3].

Stability of the metal–oxide interfaces depends markedly on the adhesion behaviour and on the specific features of the morphology of the interface. A number of theoretical studies were performed for a single Cu atom and Cu cluster adhesion on the MgO(001) surface, most of them based on the embedded and finite cluster model [4–8] which faces well known problems with boundary conditions. There also exist simulations of Cu clusters on a periodic MgO(001) slab in the framework of the Car–Parinello approach [9] and plane-wave LDA periodic slab calculations on multilayer Cu/MgO interfaces where the Cu in-plane lattice constant is stretched to that of MgO [10]. Analysis of numerous Cu/MgO interface calculations systemized by Pacchioni *et al* [6] shows a wide range of obtained adhesion energies (0.2–1.5 eV) and interfacial distances (1.85–2.15 Å). This results from use of quite different models (cluster or periodic slabs), basis sets (plane waves or localized orbitals) and methods (varied from Hartree–Fock to DFT with different exchange–correlation functionals). Meanwhile, previous *ab initio* calculations confirmed that the most attractive sites for the Cu adhesion on MgO(001) surface at low coverages are oxygen ions.

In this paper, we report results of the systematic periodic slab calculations of the regular Cu/MgO(001) interface, analysing the *trends* in physical properties as Cu coverage increases from almost single atom ($\frac{1}{4}$ ML) up to 1 ML (figure 1). The calculations for different numbers of copper adatoms are performed in the framework of the same formalism, thus allowing us a comprehensive comparative study of the dependence of the adhesion of the sub-monolayer film as a function of metal coverage. A new aspect of broad interest is that the physics of a metal bonding to the MgO substrate is essentially different for a low coverage and for a monolayer. We also trace back the in-plane changes of a charge redistribution and Cu density of states properties in sub-monolayer copper films, which is important for understanding the interface conductivity. Our simulations of the interface with successively varied adsorbate concentration are used not only for analysis of the electronic structure changes but also for theoretical prediction of the growth mode for thin metallic film on the insulating substrates, as implemented by us recently [11]. The latter theory combines systematic *ab initio* calculations on the interface with statistical thermodynamic treatment based on interatomic potentials extracted from the first principles calculations. For the defect-free Cu/MgO(001) interface, we show that the formation of well separated metal clusters is practically unavoidable, even at the initial stages of the copper film growth, in agreement with experiment [12].

2. Theoretical background

2.1. First principles calculations

The periodic DFT calculations have been carried out using the *CRYSTAL-98* code [13]. This package uses the localized, LCGTF basis set where each crystalline wavefunction is constructed as a linear combination (LC) of atom-centred Gaussian-type functions (GTFs). In the present study, we use the non-local generalized gradient approximation (GGA) for both exchange and correlation functionals, which have shown earlier very reasonable results in *CRYSTAL-DFT* calculations on the metal adhesion on the metal oxide interfaces [14]. The most appropriate description of the regular Cu/MgO(001) interface is achieved using Becke's non-local, hybrid (DFT–HF), three-parameter exchange–correlation functional *B3LYP* [15].

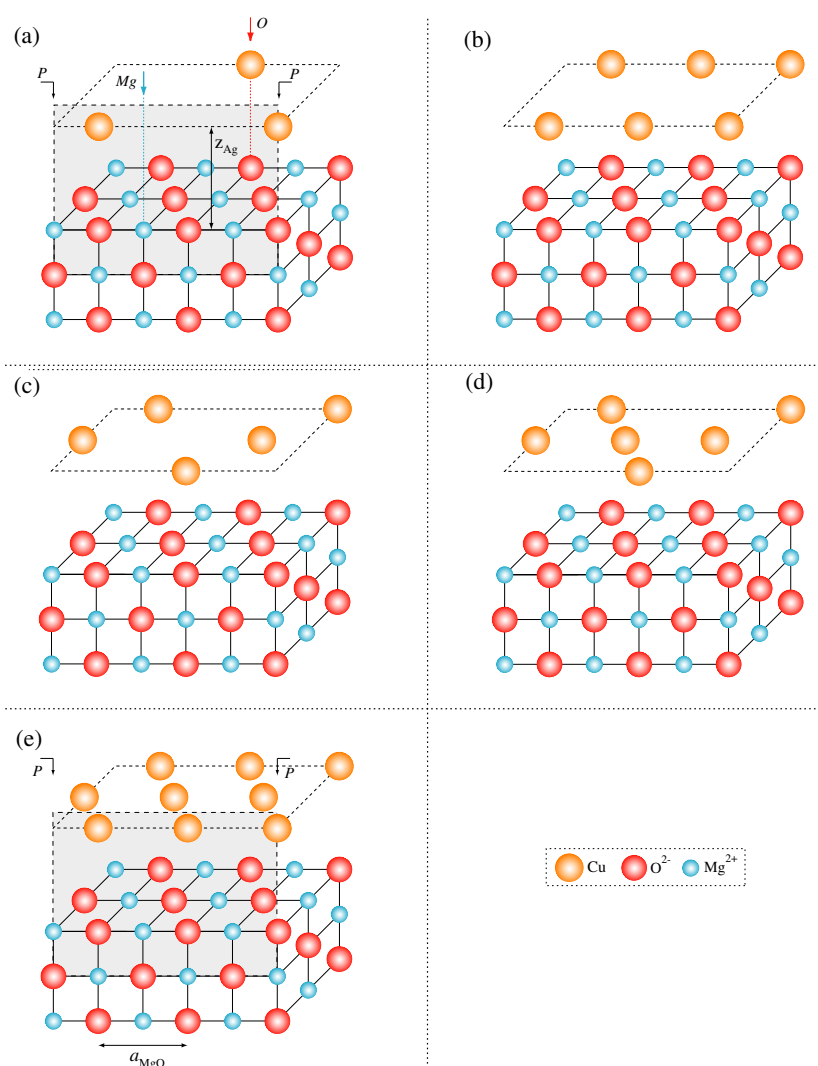


Figure 1. Fragments of the regular Cu/MgO(001) interface with $\frac{1}{4}$ ML (a), regular (net) and striped $\frac{1}{2}$ ML (b) and (c), $\frac{3}{4}$ ML (d), and 1 ML (e) coverages where Cu atoms lie in a plane at the distance z_{Cu} above surface O^{2-} ions. (a) and (e) show the cross-sections used for electron density plots (figure 3). The adsorption patterns atop the surface Mg^{2+} ions are not shown.

Another crucial point in CRYSTAL calculations is a correct choice of the basis sets (BSs) used in GTFs. The all-valence BSs for MgO optimized earlier for the CRYSTAL calculations (8s–511sp and 8s–411sp for magnesium and oxygen, respectively) [16] were found to be suitable for the present simulations, and we only slightly re-optimized the outermost shells for Mg and O. As a result, we could achieve for bulk MgO a good agreement with the corresponding experimental values for the calculated lattice constant and bulk modulus, as well as band structure in the most important HOMO–LUMO energy range (table 1) [17, 18]. However, we have re-optimized considerably the all-valence Cu BS developed elsewhere for describing copper interaction with chlorine [19], since this BS is not well suited for the Cu/MgO(001)

Table 1. Some cohesive and electronic properties of Cu and MgO crystals (lattice constant a_0 , bulk modulus B , cohesion energy per atom E_{coh} , width of the Cu conduction band $\Delta\epsilon_{\text{Cu}}^{\text{CB}}$ as well as widths of MgO energy gap at different points of Brillouin zone: $\Delta\epsilon_{\text{MgO}}^{\Gamma}$, $\Delta\epsilon_{\text{MgO}}^{\text{L}}$ and $\Delta\epsilon_{\text{MgO}}^{\text{X}}$) calculated using the *B3LYP* method for a verification of the GTF basis sets and their comparison with available experimental and theoretical data.

Crystal	Source of data	a_0^a (Å)	B^b (GPa)	E_{coh} (eV)	$\Delta\epsilon_{\text{Cu}}^{\text{CB}^c}$ (eV)	$\Delta\epsilon_{\text{MgO}}^{\Gamma^c}$ (eV)	$\Delta\epsilon_{\text{MgO}}^{\text{L}^c}$ (eV)	$\Delta\epsilon_{\text{MgO}}^{\text{X}^c}$ (eV)
Cu	<i>Our study</i>	3.68	131	3.25	9.4	—	—	—
	Experiment	3.61 ^d	138 ^d	3.51 ^d	8.6 ± 0.4^e	—	—	—
	Other calculations	3.63 ^f	155 ^f	3.89 ^f	9.3 ^e	—	—	—
MgO	<i>Our study</i>	4.24	138	—	—	6.9	12.8	14.7
	Experiment	4.21 ^g	155 ^g	—	—	7.7 ^h	10.8 ^h	13.3 ^h
	Other calculations	4.13 ^g	156 ^g	—	—	8.2 ^g	12.5 ^g	14.3 ^g

^a Calculation error is estimated to be 0.05 Å.

^b The estimated error is ≈ 5 GPa; 1 GPa = 2.29371×10^{-4} Hartree Å⁻³ = 1 GJ m⁻³ = 10⁻² Mbar.

^c The estimated error is 0.1 eV.

^d Reference [26] (experimental values were obtained in the temperature interval 273–298 K).

^e Reference [25].

^f Reference [19] (DFT-GGA GTF calculations).

^g Reference [17] (DFT plane wave calculations).

^h Reference [18].

interface [20]. We have chosen a small Hay–Wadt pseudopotential [21] for the core of the Cu atom (this procedure was quite successful in our previous Ag/MgO(001) CRYSTAL calculations [22]) and carefully re-optimized coefficients and exponents of sub-valence, valence and virtual shells (4111sp–41d GTF), in order to get the minimum of total energy per Cu atom. Optimization of basis sets has been performed using *ParOptimize* code [23] interfaced with *CRYSTAL-98* [13]. It implements the conjugated gradient optimization technique [24] with numerical computation of derivatives. With the re-optimized BS, the copper properties are described as well as by other well known first principles simulations [19, 25, 26], providing a good agreement with experimental values of the lattice constant, bulk modulus and cohesion energy [26] as well as different parameters of band structure for Cu bulk including the width of the conduction band [25] (table 1). We have also calculated several properties for pure Cu(001) slabs; in particular, the surface energy for a five-layer defect-free slab of 1540 erg cm⁻² was found to be in a quite good qualitative agreement with the experimental value of 1790 erg cm⁻² obtained for the polycrystalline sample [26].

2.2. Slab model

For the perfect MgO(001) substrate, we have used the 2D three-layer slab (figure 1). The choice of this model was justified by a comparison of the results of our previous calculations on three-, five- and seven-layer magnesia slabs with one- and two-sided metal coverages [27]. Since results were quite close, we have chosen the model which needs smaller computational resources and thus permits us to focus on a more careful structural optimization. Because the one-side ordered coverage of the magnesia slab by copper atoms was varied from $\frac{1}{4}$ ML to 1 ML, we performed the calculations for a 2×2 extended MgO(001) surface unit cell. For all five structures we optimized the total energy, as a function of the substrate lattice constant a_{MgO} and the distance z_{Cu} between the 2D lattice of Cu atoms and an underlying MgO slab. In this optimization, we have found negligible magnesia surface relaxation, which agrees with earlier studies [28].

The quality of the results of our interfacial slab calculations based on the re-optimized BS is quite good as follows from the discussion below and a comparison with the results of recent experimental studies [29–31]. The 15% mismatch of Cu and MgO lattice constants results in a strain in a metal film. However, this is not relevant for the adsorption of *single*, pseudo-isolated Cu atoms. Therefore, use of $\frac{1}{4}$ ML (figure 1(a)) and particularly *regular* $\frac{1}{2}$ ML coverage, where Cu atoms are not the nearest neighbours (figure 1(b)), on the perfect MgO(001) surface is quite justified for a simulation of the interaction between Cu atom and oxide substrate. We have also simulated three more strained adsorbate configurations: *striped* $\frac{1}{2}$ ML (figure 1(c)), $\frac{3}{4}$ ML (figure 1(d)) and 1 ML (figure 1(e)), which are used for our analysis of the *trend* in the Cu/MgO bonding as metal atom concentration increases, and for thermodynamic analysis of the growth mode (where these interfacial patterns serve as the reference structures and should not necessarily be equilibrium).

2.3. Thermodynamic method

The choice of five ordered interfacial structures shown in figure 1 is neither an accidental nor an arbitrary one; their energetics is required for the statistical method [11] developed by us to study thermodynamics and morphology of thin metallic film growth on ceramic substrate at different temperatures based on the first principles calculations at 0 K. Copper film is formed on the planar lattice placed above the MgO(001) substrate. The sites of such a lattice are placed above the surface oxygen ions, which are preferable for copper adhesion. The Cu atom lattice is immersed in the field of the electronic charge distribution created by the magnesia surface. One can treat the Cu film in terms of the 2D ‘solid solution’ Cu–E, i.e. Cu-‘empty sites’ occupied by quasi-particles, E. The thermodynamics of such a solid solution may be formulated with the help of the *effective mixing potential*

$$\tilde{V}(\mathbf{r}, \mathbf{r}') = V_{\text{Cu-Cu}}(\mathbf{r}, \mathbf{r}') + V_{\text{E-E}}(\mathbf{r}, \mathbf{r}') - 2V_{\text{Cu-E}}(\mathbf{r}, \mathbf{r}'), \quad (1)$$

where $V_{\text{Cu-Cu}}(\mathbf{r}, \mathbf{r}')$, $V_{\text{E-E}}(\mathbf{r}, \mathbf{r}')$ and $V_{\text{Cu-E}}(\mathbf{r}, \mathbf{r}')$ are the effective interatomic potentials between copper atoms, between quasi-particles and between copper atoms and quasi-particles, respectively; \mathbf{r} and \mathbf{r}' are the positions of the sites in 2D lattice. Actually, this mixing potential reflects the interaction in such a 2D system embedded into the field of the half-infinite MgO restricted by a free (001) surface. It is possible to determine the atomic fraction of Cu atoms or of E-quasi-particles in this 2D solution in a usual way. The problem of thermodynamic stability of this 2D solid solution transforms to a study of the *ordering and/or decomposition* tendencies in such a binary system on the 2D Ising lattice and may be considered in terms of the *phase diagram* of a 2D alloy, in the framework of the concentration wave (CW) approach [32].

The distribution of atoms A in a binary alloy using this approach is described by a *single occupation probability function* $n(\mathbf{r})$. This function gives the probability to find the atom A (Cu) at the site \mathbf{r} of the crystal lattice. The configurational part of the free energy of formation of the 2D solid solution per atom is given by

$$F = \frac{1}{2N} \sum_{\substack{\mathbf{r}, \mathbf{r}' \\ \mathbf{r} \neq \mathbf{r}'}} \tilde{V}(\mathbf{r}, \mathbf{r}') n(\mathbf{r}) n(\mathbf{r}') + kT \sum_{\mathbf{r}} \{n(\mathbf{r}) \cdot \ln n(\mathbf{r}) + [1 - n(\mathbf{r})] \cdot \ln[1 - n(\mathbf{r})]\}. \quad (2)$$

Here T is temperature, k the Boltzmann constant and $n(\mathbf{r})$ determines a distribution of solute atoms in an ordering phase. The summation is performed over the sites of the 2D Ising lattice.

To simulate the coating of substrate by Cu atoms, we have chosen nearly the same 2D reference structures for the occupation probability functions as described for Ag/MgO(001) earlier [11]. (Additionally, we have considered here the structure with $\frac{3}{4}$ ML coverage.) For a $\frac{1}{2}$ ‘net’ ML this is $n_1(\mathbf{r}) = c_A^{(1)} + 0.5 \eta \cdot e^{2\pi i x}$ and for a $\frac{1}{2}$ ‘striped’ ML $n_2(\mathbf{r}) = c_A^{(2)} + 0.5 \eta \cdot e^{\pi i(x+y)}$,

Table 2. Parameters of the Cu/MgO(001) interface obtained in our calculations and their comparison with previous periodic slab calculations.

Cu atom over	Substrate coverage		Distance to MgO surface ^a $z_{\text{Cu}}^{(0)}$ (Å)	Adhesion energy per Cu ^b E_{adh} (eV)	Charge transfer Δq_{Cu}^c (e)
O^{2-} ion	$\frac{1}{4}$ ML		2.08	0.62	0.047
			1.9 ^d	1.4 ^d	0.03 ^d
	$\frac{1}{2}$ ML	Regular	2.11	0.65	0.018
		Striped	2.25	0.37	0.003
	$\frac{3}{4}$ ML		2.21/2.38 ^f	0.34/0.32 ^f	0.002/−0.006 ^f
	1 ML		2.36	0.33	−0.007
Mg^{2+} ion	$\frac{1}{4}$ ML		2.0 ^e	1.0 ^e	−0.08 ^e
			2.63	0.48	−0.027
	$\frac{1}{2}$ ML		2.5 ^d	0.5 ^d	—
		Regular	2.38/2.68 ^f	0.42/0.38 ^f	−0.016/−0.022 ^f
	$\frac{3}{4}$ ML	Striped	2.78	0.26	−0.014
			2.87	0.20	−0.013
	1 ML		2.98	0.13	−0.003
		3.20 ^e	0.2 ^e	−0.06 ^e	

^a The estimated error is 0.05 Å.

^b The basis set superposition error is ≈ 0.1 eV.

^c The estimated error is 0.05 e ; a positive sign means an excess of the electron charge as compared to a neutral atom.

^d Reference [5] (cluster calculations).

^e Reference [10] (slab calculations).

^f For two local minima.

whereas the occupation function for $\frac{1}{4}$ ML is extended now for the case of $\frac{3}{4}$ ML using a modified definition:

$$n_3(\mathbf{r}) = c_A^{(3)} + \gamma\eta_1 e^{2\pi i x} + \gamma\eta_2 [e^{\pi i(y+x)} + e^{\pi i(y-x)}], \quad (3)$$

where x and y are the coordinates of the lattice sites of the Ising lattice, in the lattice parameter units. The stoichiometric compositions of these ordered 2D phases are $c_A^{(1)} = c_A^{(2)} = \frac{1}{2}$, $c_A^{(3)} = \frac{1}{4}$ or $\frac{3}{4}$ for $\gamma = \frac{1}{4}$ or $-\frac{1}{4}$, respectively. It is easy to check by a direct substitution of coordinates of the Ising lattice sites that for these structures in the ordered states and stoichiometric compositions the occupation probabilities are equal to unity in the sites occupied by Cu atoms and are equal to zero in the empty sites. The internal formation energies for these phases (U_1 , U_2 and U_3) were defined previously [11], via Fourier transforms of the mixing potential described in equation (1) as well as the long-range order parameters η , η_1 and η_2 which are also equal to unity for the ordered phases and are zero for the absolutely disordered state. The total energies of the ordered superstructures are calculated using the *B3LYP* method (see section 2.1).

3. *Ab initio* simulation of the ordered interface patterns

For all calculated adsorbate structures, we found that the equilibrium value of a_{MgO} is practically the same, while z_{Cu} considerably changes (table 2). Figure 2 shows the binding interfacial energy E_b versus z_{Cu} for different Cu coverages over both Mg^{2+} and O^{2-} ions whereas table 2 presents the equilibrium z_{Cu} values, the adhesion energy and effective atomic charges on adatoms for all considered configurations. We observe a marked difference in adhesion energies

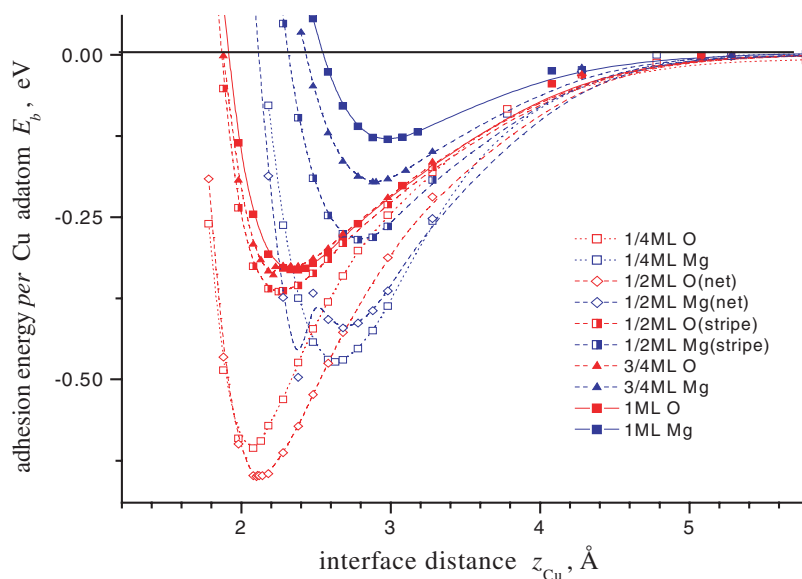


Figure 2. The adhesion energy E_b as a function of z_{Cu} for two different adsorption sites, Mg^{2+} and O^{2-} (figure 1), and five differently ordered Cu coverages, $\frac{1}{4}$ ML, $\frac{1}{2}$ ML (net and stripe distributions), $\frac{3}{4}$ ML and 1 ML, on the $\text{MgO}(001)$ substrate.

for a low Cu coverage, when adatoms are placed over surface Mg^{2+} or O^{2-} ions: the relevant adsorption energy over magnesium ions is smaller by 30% than that over oxygen ions, which is accompanied by a substantial increase of the interfacial distance. As Cu coverage increases from $\frac{1}{4}$ to $\frac{1}{2}$ (a regular distribution), the adhesion energy for Cu atoms over O^{2-} ions increases to 0.65 eV (table 2 and figure 2). This can be explained by an additional interaction for $\frac{1}{2}$ ML between Mg^{2+} ions and an excessive electron density concentrated in the interstitial positions between Cu atoms. We also found that the adsorption of Cu atop both surface O^{2-} ions for a $\frac{3}{4}$ ML and Mg^{2+} ions for a $\frac{1}{2}$ net ML results in an unusual *two* local minima on the energy curves versus z_{Cu} (figure 2). These arise due to a delicate interplay of the different spin states: the energy minimum closest to the surface corresponds to the *triplet* spin state whereas another minimum belongs to the *singlet* spin state. The existence of the two local minima on the adhesion curve reflects the complicated nature of the Cu polarization: the minimum closest to the surface is characterized by the substantial Cu electronic charge repulsion from the surface, i.e. the Cu atom becomes a highly polarized dipole, whereas another minimum is caused by the quadrupole interactions of this atom with the surface.

When passing to the $\frac{1}{2}$ ML striped configuration, $\frac{3}{4}$ ML and 1 ML, the adhesion energy of Cu over O^{2-} ions becomes sufficiently smaller, 0.37, 0.34 and 0.33 eV, respectively. This is very likely result of a stress and/or specific features of the electron charge density redistribution in an artificially expanded metal ‘stripe’ or monolayer. The relevant interface distances considerably exceed those for a regular $\frac{1}{2}$ ML and $\frac{1}{4}$ ML (table 2). This is well correlated with the recent x-ray absorption measurements [29], which show that the interfacial distance $z_{\text{Cu}-\text{O}^{2-}}$ should be larger than the analogous distance in the copper oxide bulk (1.88–1.97 Å) but smaller than the nearest-neighbour distance in the Cu bulk (2.55 Å). In a line with this, as copper coverage increases, our equilibrium distance for a pseudo-isolated adatom (≈ 2.1 Å) increases as well (to 2.2–2.3 Å), becoming closer to the interatomic distances in the copper aggregates. Recently, using microcalorimetry [31], an initial heat of Cu adhesion on the $\text{MgO}(001)$ substrate was

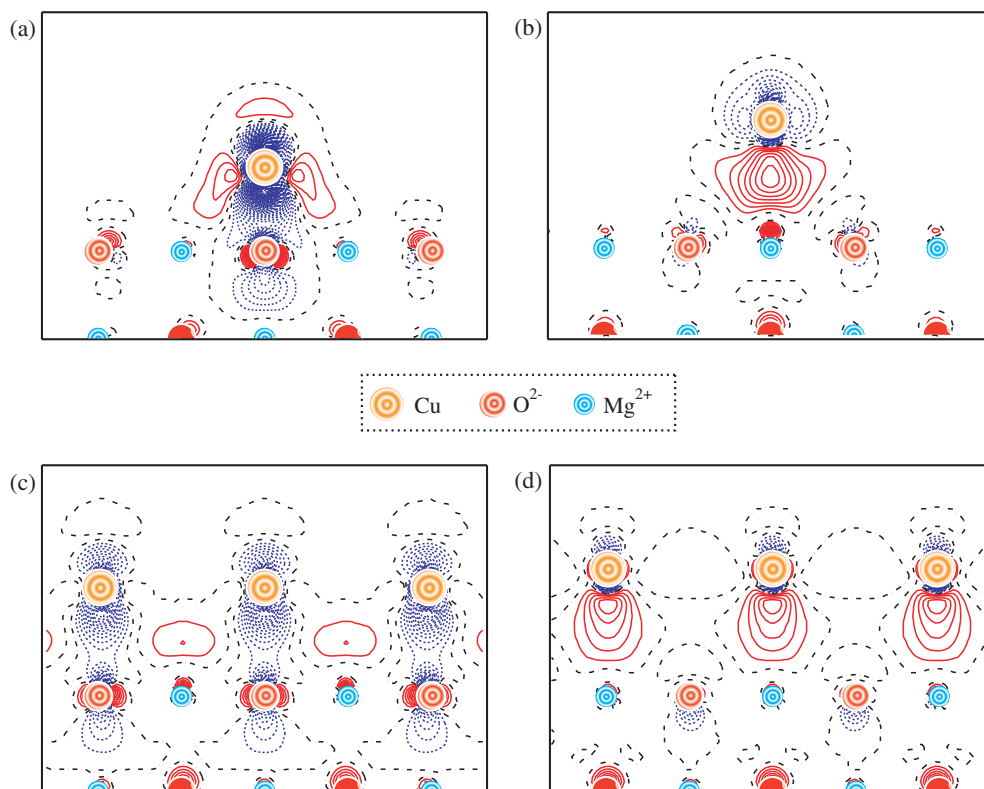


Figure 3. The difference electron density maps $\Delta\rho(\mathbf{r})$ (the total density minus a superposition of the densities for the isolated Cu and MgO slabs) in the cross-section perpendicular to the (001) interface plane (figures 1(a), (e)) for two different copper coverages: (a) $\frac{1}{4}$ Cu ML over a O^{2-} surface ion; (b) $\frac{1}{4}$ Cu ML over a Mg^{2+} surface ion; (c) 1 ML over a O^{2-} ; (d) 1 ML over a Mg^{2+} . Isodensity curves are drawn from -0.05 to $+0.05e \text{ au}^{-3}$ with increments of $0.001e \text{ au}^{-3}$. The full, dashed and chained curves show positive, negative and zero difference electron densities, respectively.

estimated to be as large as 2.4 eV per adatom, which is much larger than our or any other theoretical prediction for the Cu binding energy. Although this thermodynamic parameter is not the same as an adsorption energy, the discrepancy is too large and we suppose that it is a trapping of mobile Cu atoms at surface defects which very likely causes such a large heat of adhesion. (An important role of surface defects in the enhanced Cu bonding on the MgO(001) substrate was also observed experimentally [12].) Thus we believe that our prediction for Cu binding energy on the perfect MgO(001) surface (0.6–0.8 eV per adatom) is correct.

The calculated Mulliken charges on Cu atoms indicate either a negligible charge transfer towards adatoms from surface O^{2-} ions for $\frac{1}{4}$ and $\frac{1}{2}$ ML coverages, or very small charge donation towards a substrate for other interfacial configurations (table 1). However, the latter is within the limits of the accuracy of the Mulliken population analysis ($\approx 0.05e$). Meanwhile, the bond populations between metal atoms and substrate ions across the interface are practically zero. The electron charge re-distribution in several interface patterns shown in figure 3 gives the most convincing argument in favour of a decisive role of the *electrostatic* interaction between polarized Cu atoms and surface O^{2-} ions as the *physisorption* mechanism of Cu thin film adhesion on the perfect MgO(001) substrate. A comparison of the electron density

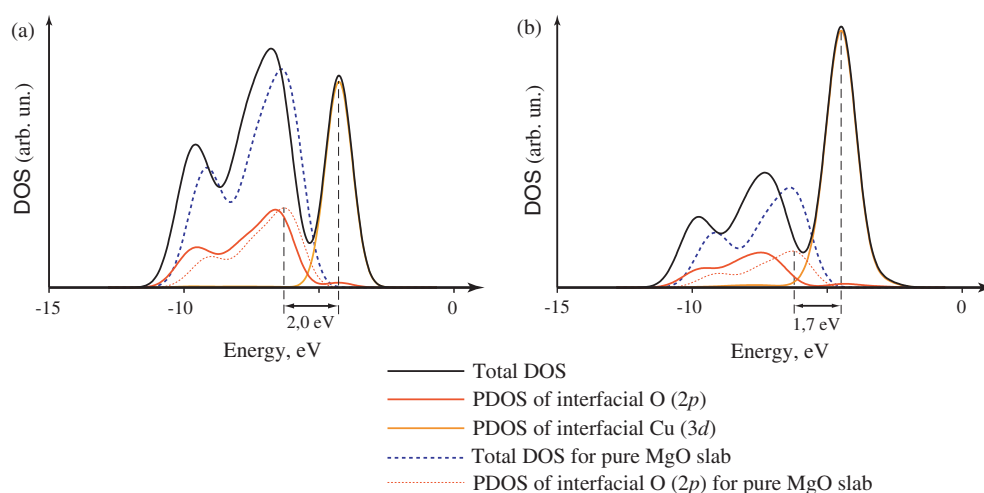


Figure 4. Total and projected DOS for the two different Cu substrate coverages: $\frac{1}{4}$ ML (figure 1(a)) and 1 ML (figure 1(e)). The largest peaks were normalized to the same value whereas a convolution of individual energy levels was plotted using the Gaussians with a half-width of 0.8 eV.

plots for $\frac{1}{4}$ ML in figures 3(a) and (b) indicates that single Cu atoms are more distorted above surface O^{2-} ions (where the charge transfer from the substrate is also greater) rather than above Mg ions. The same is true for a noticeable polarization of both nearest and next-nearest surface O^{2-} ions, while electronic shells of Mg^{2+} ions are not affected too much by Cu adatoms. The contribution of the subsurface substrate ions to the bonding of copper adatoms is also negligible. As the Cu coverage grows, the electron density re-distribution for 1 ML (figures 3(c) and (d)) clearly demonstrates the appearance of an additional extra charge density concentrated in hollow positions between Cu atoms. For the Cu adsorption above surface O^{2-} ions, this extra charge has an attractive interaction with the surface Mg^{2+} ions below it, whereas for an alternative 1 ML interface (figure 3(d)), in contrast, a repulsion occurs between the Cu interatomic density and surface oxygen ions. At 1 ML, we have also observed a noticeable bond population between nearest Cu atoms ($0.075e$ per atom) within the metal plane, which is not sensitive to the particular adsorption site. These peculiarities of the electronic structure can lead to substantial changes in conducting properties that could be important for microelectronic applications.

Analysis of the density of states (DOS) for the Cu layer (see figure 4) confirms substantial changes in conductive electron distributions for different Cu coverages. The oxygen states $O(2p)$ are very sensitive to the change of metal coverage. For net-type coatings ($\frac{1}{4}$ ML and $\frac{1}{2}$ ML), we observe a pseudo-gap (the energy difference between the magnesia $O(2p)$ and $Cu(3d)$ peaks). Obviously, the largest pseudo-gap occurs for the $\frac{1}{4}$ Cu ML (figure 4(a)). However, this pseudo-gap begins to diminish for the striped $\frac{1}{2}$ ML configuration and higher 1 ML coverage (figure 4(b)). At the same time, projections of $Mg(3p)$ states were found to be negligible to make any contribution to the interaction in the $Cu/MgO(001)$ interface. Our results are close to those of x-ray emission spectroscopy [30] where the gap between magnesia and copper peaks was found to be ≈ 1 eV.

The sensitive balance of the attraction and repulsion of polarized Cu atoms in the vicinity of the substrate defines the distance between a Cu sub-monolayer plane and the underlying MgO slab. We found also an increase of in-plane metallic bonding between Cu adatoms when

Cu atomic fraction increases. This leads to a simultaneous decrease of Cu adatom polarization, which together with a strain-induced repulsion results in a decrease of the physisorption-type bonding. As a consequence, with an increase of the fraction of adatoms the distance between the 2D lattice of Cu atoms and underlying MgO slab also increases, while the adhesion energy for Cu shows the opposite tendency. Our calculations of the adhesion curve show that the process of the metal adatom approaching the oxide surface may be rather unexpected. It may include several (in our case, two) local minima. This means that depending on the temperature and the kinetic energy of the metal atoms, they may be localized at different distances from the substrate surface, thus complicating the morphology of the growing thin metallic film. We produced self-consistent calculations thoroughly enough to be sure in this double-well structure, which is caused by a delicate interplay of the different spin states. (We shall discuss the triplet states of the Cu/MgO interface and possible issues of its magnetic behaviour in a separate study.) The existence of a metastable energy profile with several minima could be important for the adsorption theory and for catalytic models. Moreover, a comparison of two different copper adatom configurations, corresponding to the same $\frac{1}{2}$ ML coverage (figures 1(b) and (c)), allows us to predict the tendency to formation of Cu clusters on MgO(001) surface.

4. Thermodynamic analysis of ultra-thin-film growth

The energy of heterogeneous mixture of the components of the Cu–E ‘solid solution’ (section 2.3) was chosen in a conventional way as the *reference state* energy [33]. In our case it is calculated as the sum of weighted (with atomic fractions) total energies per lattice site for the ‘empty’ lattice above the MgO(001) surface (i.e. pure magnesia substrate) and the lattice filled by Cu atoms above the same MgO slab (1 ML). Since for completely ordered states all long-range order parameters are equal to unity, we obtain the formation energies for the 2D superstructures at different distances z_{Cu} from the MgO(001) surface, performing the *B3LYP* calculations on ordered adsorbate patterns atop the three-layer slab model of magnesia substrate. All these energies are positive, i.e. such ordered phases are unfavourable as compared with the reference state. Thus, decomposition in 2D Cu–E solid solution into two phases with different morphologies should occur even at $T = 0$ K. When T increases, the spinodal decomposition in the Cu–E ‘alloy’ takes place. To analyse this decomposition, the further thermodynamic study should be carried out.

The condition $n(\mathbf{r}) = c_A = \text{constant}$ corresponds to the case of disordered 2D solid solution. This gives the *free energy* of the solid solution defined by equation (2):

$$F(c) = -\frac{1}{2}\tilde{V}(0) \cdot c(1 - c) + kT [c \ln c + (1 - c) \ln(1 - c)], \quad (4)$$

where $\tilde{V}(0)$ is the Fourier transform of the effective mixing potential defined by equation (1) for the zero wavevector, $\mathbf{k} = \mathbf{0}$. We found that for different structures, which correspond to different atomic fractions of Cu, the equilibrium distance from the MgO substrate increases from 2.08 to 2.36 Å as the atomic fraction grows from $\frac{1}{4}$ ML to 1 ML. Expressing the values of the internal formation energies U_1 , U_2 and U_3 (section 2.3) for completely ordered structures, we obtain the dependence of the energy parameter $\tilde{V}(0)$ on the interfacial distance, z_{Cu} (figure 5(a)). This dependence is related to the previously discussed changes in Cu–MgO(001) interactions when the number of Cu atoms on the 2D lattice changes and reflects partly the response of the system to mismatch of the Cu layer and the MgO(001)-terminated substrate. This dependence may be translated into the dependence of $\tilde{V}(0)$ on the atomic fraction of Cu, c , as displayed in figure 5(b). The latter is almost linear, and is well fitted by the function $\tilde{V}(0)(c) = -0.6858 - 0.0823c$. Substituting this result into equation (4) we obtain the *asymmetric* dependence of the free energy of the *disordered* Cu–E solid solution on the

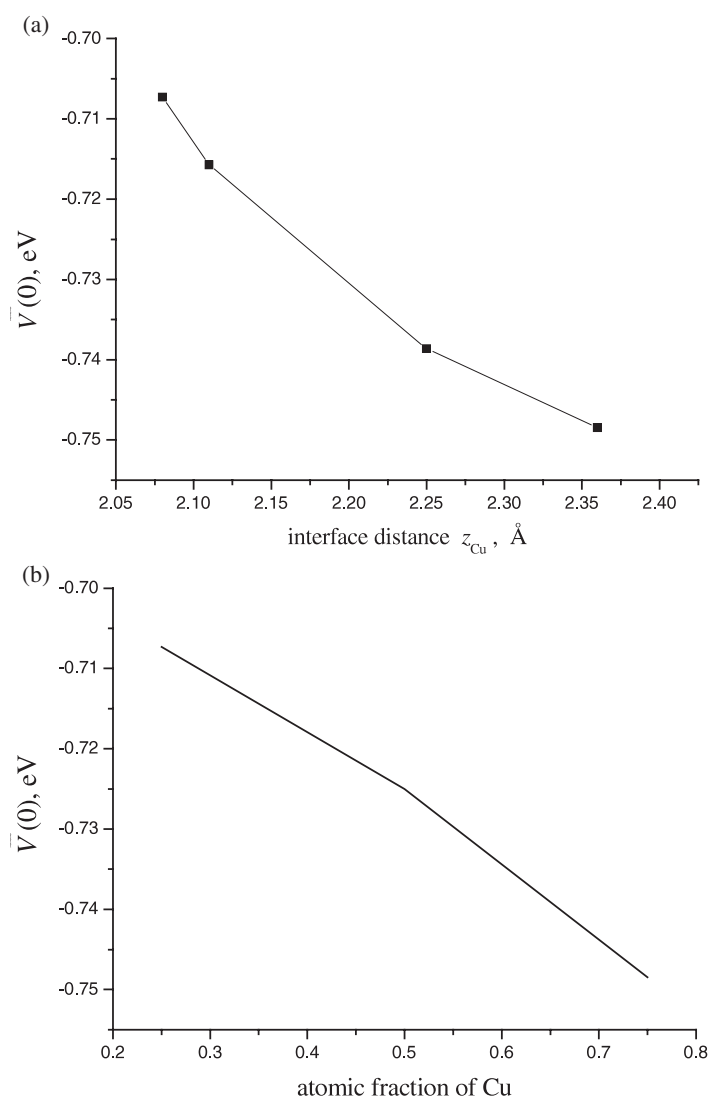


Figure 5. The calculated dependences of the energy parameter $\tilde{V}(0)$ on both the interfacial distance z_{Cu} (a) and the atomic fraction of Cu in the layer which was used in the calculations of the phase diagram of the 2D Cu–E solid solution (b).

composition. This result gives the so-called *sub-regular* solid solution, and the corresponding *phase diagrams* for the Cu/MgO(001) interface with the solubility and spinodal curves are presented in figure 6.

The phase diagram represents the case of the limited solubility in a binary 2D Cu atom–‘empty site’ quasi-particle solid solution. The *solvus* is shown in figure 6 by the solid curve, whereas the dotted curve shows the *spinodal*. The solubility curve is determined by the necessary minimum condition, $dF(c)/dc = 0$, whereas the spinodal curve is given by the equation $d^2F(c)/dc^2 = 0$. The phase diagram shown in figure 6(a) finds a pronounced asymmetry of the two-phase region with respect to equiatomic composition, $c = 0.5$. This is a direct consequence of the *concentration dependence* of the energy parameter $\tilde{V}(0)$. The

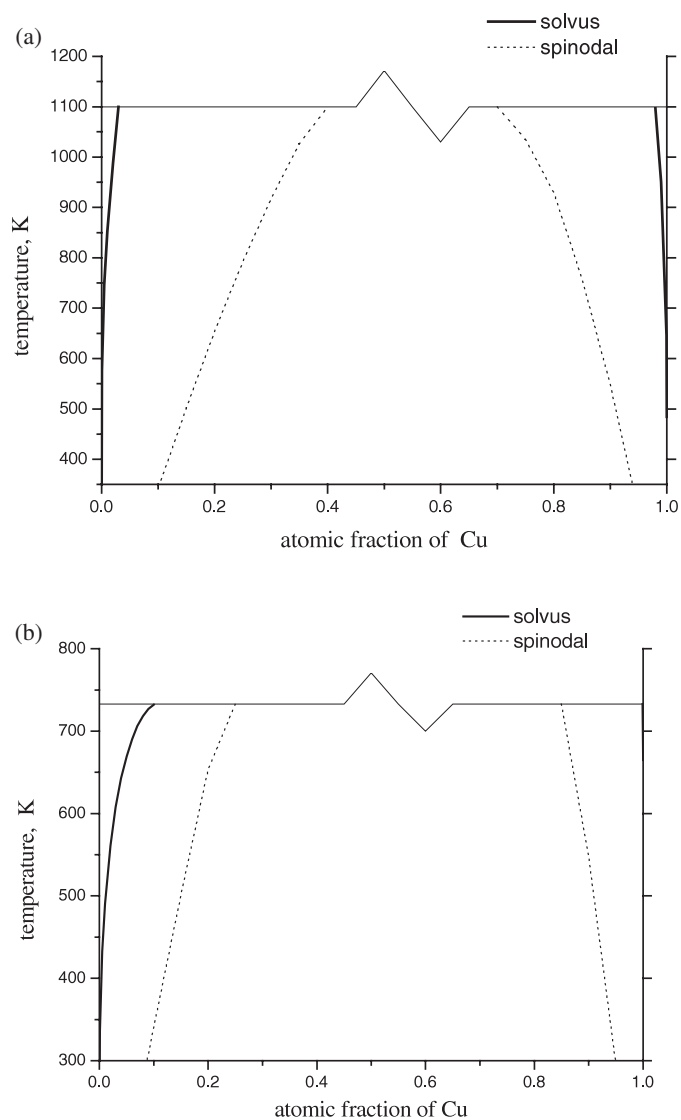


Figure 6. (a) The calculated phase diagram of the 2D Cu–E solid solution. The asymmetric behaviour of the *solvus* and the *spinodal* curves with respect to equiatomic composition is clearly seen. This is a result of the concentration dependence of the energy parameter $\tilde{V}(0)$. (b) The same phase diagram as (a) with incorporation of the lattice mismatch effect. For details see text.

decomposition of this solid solution may be analysed in the spirit of our previous study for the Ag/MgO interface [11]. As follows from thermodynamic consideration for relatively small amounts of Cu in the sub-monolayer film, in the region between the *solvus* and *spinodal* well separated and compact Cu-rich 2D clusters are expected, while under the temperature and concentration conditions when the system falls below the spinodal, the loose, wormlike morphology of the film should arise. In the particular Cu/MgO case this region is rather wide. For example, at $T \approx 1000$ K isolated 2D Cu clusters with the local fraction of Cu atoms $c = 0.97$ are formed, whereas the mean concentration of Cu in the monolayer is varied from 0.02 to 0.3.

The existence of the linear term, additionally to the term proportional to $c(1 - c)$, in the mixing free energy for solid solutions, as defined by equation (4), is usually associated with accounting for the difference in the layer tensions between pure constituents in A–B solid solution and for the atomic size mismatch [34]. In our case this term appears as the result of the optimization of the distance between the Cu layer and the MgO substrate. The dependence of the equilibrium distance z_{Cu} on c is clearly linked to the changes in the bonding between the underlying MgO and Cu atoms in the film, when Cu atomic fraction in the layer changes. The effect of the mismatch between the Cu layer and MgO on the phase diagram is also of great importance. For this purpose, following [34] (see also references therein), we have added the enthalpy term $\Delta H c$ to equation (4), where ΔH accounts for the atomic size mismatch energy. This value is not well defined and its measurement is also difficult. We have chosen $\Delta H = 150$ meV, assuming that $\Delta H = [E_{\text{adh}}(c_{\text{Cu}} = 1) - E_{\text{adh}}(c_{\text{Cu}} = \frac{1}{4})]/2$. In other words, we suppose that as the atomic fraction of Cu in the layer increases from almost separated Cu atoms in the layer to 1 ML coverage the change in the adhesion energy, E_{adh} , comes in equal fractions from the energy change due to both chemical bonding and the tensile stress caused by mismatch. The values E_{adh} are taken from our first principles calculations (table 2). Although this is a crude approximation, it permits us to illustrate the effect of mismatch on the topology of the phase diagram as shown in figure 6(b). One can see that accounting for mismatch makes the phase diagram less symmetrical with respect to equiatomic composition ($c = 0.5$) as compared with figure 6(a). At the same time, for conditions discussed in the previous paragraph, the system at room temperature (RT) finds itself still in the two-phase region between the *solvus* and *spinodal*, while Cu clusters, according to the lever rule, will include even fewer empty sites than those predicted from figure 6(a) (no mismatch). Actually, in this case the solubility curve for large atomic fractions of Cu is very close to the y -axis. That is, accounting for mismatch, on the one hand, does not change the general conclusion about the formation of almost perfect, well separated Cu clusters in the sub-monolayer deposition. On the other hand, the mismatch may be decreased sufficiently by the formation of the misfit dislocations at the interface between the substrate and the film.

Continuing to explore the idea of the Cu–E solid solution, it is also possible to understand qualitatively the formation of Cu clusters or even 3D Cu islands in a somewhat different way. Let us assume the existence of a 3D Cu–‘empty site’ quasi-particle solid solution on the Ising lattice. The sites of such a 3D lattice are situated above oxygen atoms, and the lattice is immersed in the field of the electronic charge distribution created by the magnesia surface just as it was in the 2D case. The lattice sites of this 3D lattice are partly occupied by Cu atoms. Thus, we have a system that contains a half-infinite MgO(001) and a half-infinite Cu–E separated by the distance z_{Cu} . The formation of 2D clusters discussed above may be considered as the segregations of Cu onto the first plane of such a lattice, which lies at the distance z_{Cu} from MgO(001). These 2D segregations may serve as the nuclei of Cu islands. When additional Cu atoms beyond the 1 ML regime are deposited on MgO, they are attached to the already existing 2D clusters and the formation of the 3D islands occurs, with the height of several layers at the surface of the semi-infinite Cu–E lattice. This means that the formation of 3D Cu clusters could be considered as Cu segregation on the surface of the Cu–E solid solution.

The identity of the thermodynamic approaches in the study of segregation and adsorption at the interface is discussed in [35]. It is well known that in the case when the surface segregation of component A on the surface of an A–B alloy occurs the concentration profile of surface segregation for this component decreases from the surface into the bulk [36]. It may decrease from rather large values, close to unity, to the average atomic fraction of component A in the bulk. For our Cu–E solid solution this means decreasing number of Cu atoms in successive

planes in the direction from the MgO surface. That is, when the growth of the second Cu layer in the island occurs above the already existing 2D cluster in the first plane, the number of Cu atoms in the layer second from the surface is smaller. The same occurs for the third, fourth etc layers and thus leads to the formation of 3D Cu islands having specific geometric structure—the higher the layer from the basis of the island, the smaller the effective area occupied by Cu atoms. Indeed, if the atomic fractions, c_p , in each layer, p , *inside the island were the same*, it is easy to estimate that the area of the layer $(p + n)$ in the island should satisfy the condition $S_{p+n}/S_p = \bar{c}_{p+n}/c_p$, where S_{p+n} and S_p are the areas of layers $(p + n)$ and p inside the 3D island, and \bar{c}_{p+n} is the averaged atomic fraction of Cu in the $(p + n)$ th layer from the MgO surface. Then, at the top of such a 3D Cu island we may have the area that includes the number of sites that with respect to the total number of sites in the basic layer of island equals \bar{c}/c_0 , where \bar{c} is the average fraction of Cu atoms in Cu–E 3D solid solution and c_0 is the fraction of Cu atoms in the basis layer of the island. Thus, the height of the islands in some sense is defined by the shape of the concentration profile for the surface segregation in Cu–E 3D solid solution. In principle, it is also possible to restore the shape of the 3D island.

In the framework of this model it is also possible to estimate the surface segregation energy, E_{segr} , for Cu islands on MgO(001), using the phase diagram in figure 6(a). By definition, the surface segregation energy is the energy cost of transferring one impurity atom from the bulk of a host crystal to its surface and thus may be calculated as the difference in the total energy of the system with the impurity in a surface layer and in the bulk. In the case when the ordering effects at the surface are absent (our case of the Cu–E solid solution), it was shown [36] that the Langmuir–McLean relation

$$E_{\text{segr}} = kT \ln \frac{\bar{c}(1 - c_{\text{surf}})}{c_{\text{surf}}(1 - \bar{c})} \quad (5)$$

holds quite well. Using this relation, we estimate at $T = 300$ K and $\bar{c} = 0.3$ that $E_{\text{segr}} = -0.416$ eV. This may serve as an additional confirmation of our statement that the formation of Cu islands on the ideal MgO(001) surface in normal conditions is almost unavoidable.

5. Summary

For a comprehensive study of the perfect Cu/MgO(001) interface, we have combined here first principles DFT GGA-LCGTF slab calculations with the thermodynamic formalism, which permits us to construct the *phase diagram* of the Cu-‘empty site’ quasi-particle solid solution. One of the general conclusions is that there is no Cu chemisorption or strong ionic bonding on the defectless non-polar (001) magnesia surface. For all considered coverages, the position of the polarized Cu adatom atop the surface O^{2-} ion is the energetically preferable over that atop Mg^{2+} . For the isolated Cu adatom, $E_{\text{adh}} = 0.62$ eV and $z_{\text{Cu}} = 2.08$ Å. The sensitive balance of the attraction and repulsion of polarized Cu atoms in the vicinity of the substrate affects the equilibrium distance between the Cu plane and the MgO slab. An increase of in-plane metallic bonding between Cu adatoms as the atomic fraction increases leads to a simultaneous decrease of polarization of Cu adatoms and of the *physisorption*-type binding energy.

The phase diagram for the Cu-‘empty site’ lattice predicts the decomposition of the solid solution into the two disordered phases. One of these phases is very rich in Cu atoms (compact and dense Cu clusters), while the second one is highly impoverished by them (almost empty lattice). The diagram has very narrow solubility limits and a wide asymmetric region between the *solvus* and *spinodal*. For low Cu coverage, this means that the formation of well separated 2D Cu clusters is almost unavoidable at the very initial stages of the Cu film growth on the

MgO(001) substrate, in agreement with experiment [12]. Further formation of 3D Cu islands may be considered in terms of Cu segregation onto the first Cu plane at the distance z_{Cu} above the MgO(001). We estimated the segregation energy for Cu clusters growing on MgO as $E_{\text{segr}} = -0.416$ eV at 300 K.

During the film growth due to Cu deposition from the gaseous phase at RT and atmospheric pressure, the surface density of adatoms in a gas phase is $\sim 10^{13}$ atoms cm^{-2} whereas the density of all O sites on the perfect MgO(001) substrate is $\sim 10^{15}$ sites cm^{-2} . Thus, the real atomic fraction of adatoms in the first Cu layer is about 1%. As follows from figure 6(a), we expect at RT well separated Cu clusters with very high (close to unity) atomic fraction of Cu. The question arises of what could be done to manufacture more-or-less homogeneous ultra-thin Cu film on the MgO substrate. The solution may be straightforward: we have to change the phase equilibrium conditions in the system, either by changing the external thermodynamic conditions (temperature, pressure) or by changing the fine interactions between Cu atoms in the field of the underlying MgO substrate. The latter may be done under special treatment of the MgO substrate, either by formation of surface F-centres (oxygen vacancy with two electrons) or by its saturation with some impurities before deposition of Cu atoms. This may turn out to be a quite far-sighted way to improve the quality of deposited metallic film. At the same time, increase of the temperature during the manufacturing of copper film over magnesia (aimed to form a single-phase disordered solid solution above the solvus) can hardly help because of the very small adhesion energy of Cu film on the substrate. The high-pressure processing of this film may help to create a more uniform Cu layer since the external pressure applied to the system may increase the solubility (considering the phase diagram with limited solubility of components), thus lowering the solvus curve and enforcing the formation of the disordered Cu–E solid solution. At the same time the necessary pressure may be rather high.

Recent achievements in microelectronics and other high technologies demonstrate a growing necessity in improving and further developing copper applications [37]. One of the most pressing issues is an increasing demand for epitaxially grown Cu films on non-conducting substrates and fabrication of smooth copper films, to serve as a growth template for device structures, such as tunnelling magneto-resistance devices [38]. In this sense Cu is an example of the first series transition metals used as magnetic layers. Further theoretical studies of the morphology of a Cu layer on MgO, thermodynamics of thin-film/3D cluster growth, their magnetic properties and adhesion on surface *defects* and on a modified MgO surface with a seed metal layer [39] are of great interest.

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